

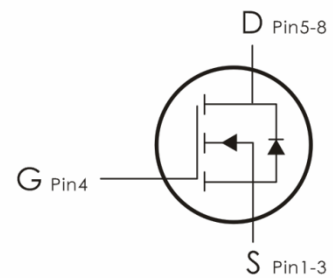
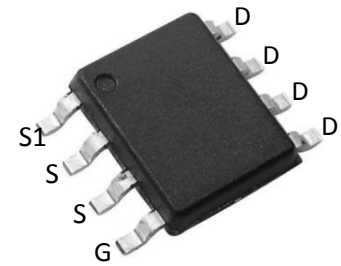
Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=60V, I_D=7A, R_{DS(ON)} < 32m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra $R_{DS(ON)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous ($T_C=25^\circ C$)	7	A
	Drain Current - Continuous ($T_C=100^\circ C$)	3.8	
I_{DM}	Drain Current - Pulsed ¹	20	
P_D	Power Dissipation ($T_C=25^\circ C$)	1.5	W
	Power Dissipation - Derate above $25^\circ C$	---	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	36	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	85	

Package Marking and Ordering Information:

Part NO.	Marking	Package
DOS7N06	7N60	SOP-8

Electrical Characteristics: ($T_C=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Sourctce Breakdown Voltage	V _{GS} =0V, I _D =250 μ A	60	---	---	V
ΔBVDSS/ΔT _J	BVDSS Temperature Coefficient	Reference to 25℃ , I _D =1mA	---	0.63	---	V/℃
I _{DSS}	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =25℃	---	---	1	uA
		V _{DS} =0V , V _{GS} =0V , T _J =125℃	---	---	10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =± 20V, V _{DS} =0V	---	---	± 100	nA
On Characteristics						
V _{GS(th)}	GATE-Source Threshold Voltage	V _{GS} =V _{DS} , I _D =250 μ A	1.2	---	2.5	V
ΔVGS(th)	VGS(th) Temperature Coefficient		---	-5.24	---	mV/℃
R _{DS(ON)}	Static Drain-Source On Resistance	V _{GS} =10V, I _D =4A	---	---	32	m Ω
		V _{GS} =4.5V, I _D =2A	---	---	45	
G _{FS}	Forward Transconductance	V _{DS} =5V, I _D =4A	---	21	---	S
Dynamic Characteristics ⁴						
C _{iss}	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz	---	1350	---	pF
C _{oss}	Output Capacitance		---	85	---	
C _{rss}	Reverse Transfer Capacitance		---	60	---	
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time ^{2,3}	V _{DD} =30V, I _D =4A, R _{GEN} =3.3 Ω , V _{GS} =10V	---	8	---	ns
t _r	Rise Time ^{2,3}		---	14.2	---	ns
t _{d(off)}	Turn-Off Delay Time ^{2,3}		---	24.4	---	ns
t _f	Fall Time ^{2,3}		---	4.6	---	ns

Q_g	Total Gate Charge ^{2,3}	V _{GS} =4.5V, V _{DS} =48V, I _D =4A	---	12.6	---	nC
Q_{gs}	Gate-Source Charge ^{2,3}		---	3.2	---	nC
Q_{gd}	Gate-Drain “Miller” Charge ^{2,3}		---	6.3	---	nC
Drain-Source Diode Characteristics						
V_{SD}	Source-Drain Diode Forward Voltage ³	V _{GS} =0V,I _S =1A,T _J =25℃	---	---	1.2	V
I_S	Continuous Source Current	VG=VD=0V , Force Current	---	---	4.8	A
I_{SM}	Pulsed Source Current		---	---	9.6	A

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=22.6A$
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics: ($T_C=25^\circ C$ unless otherwise noted)

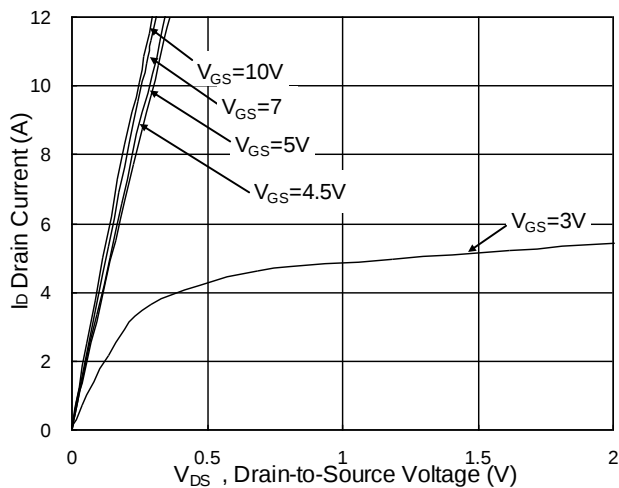


Fig.1 Typical Output Characteristics

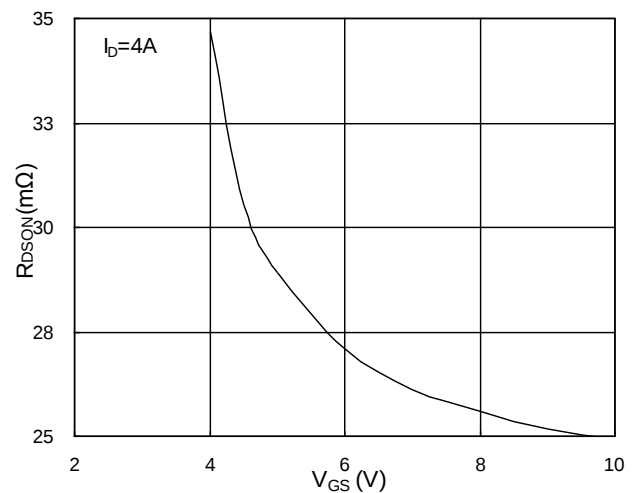


Fig.2 On-Resistance v.s Gate-Source

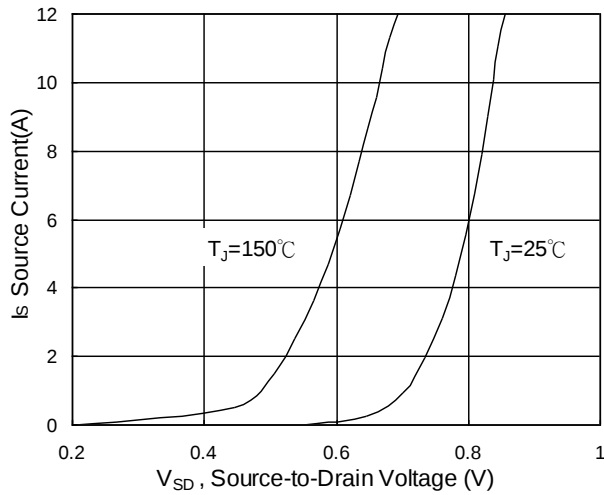


Fig.3 Forward Characteristics of Reverse

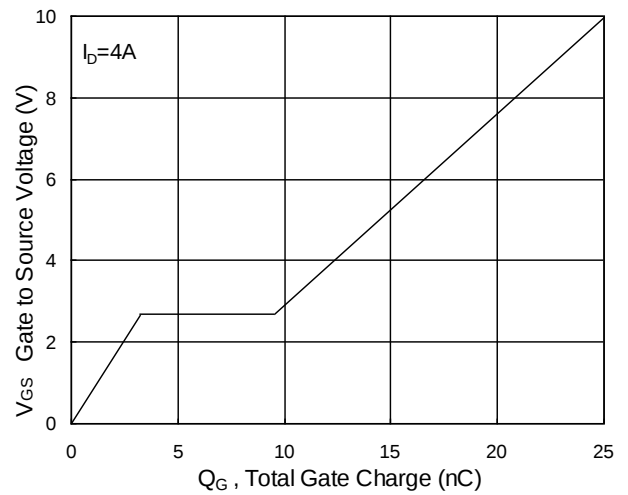


Fig.4 Gate-Charge Characteristics

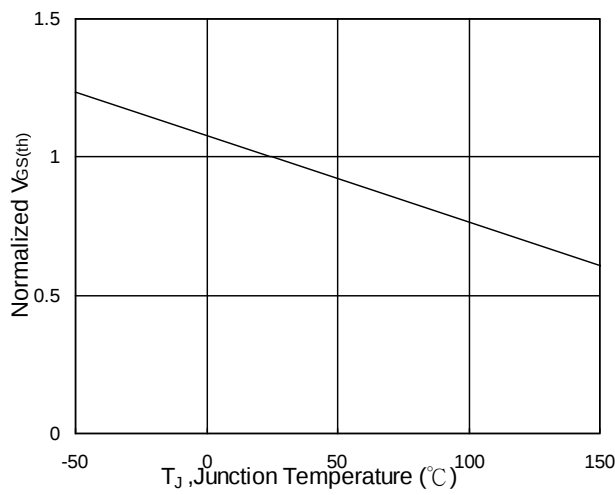


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

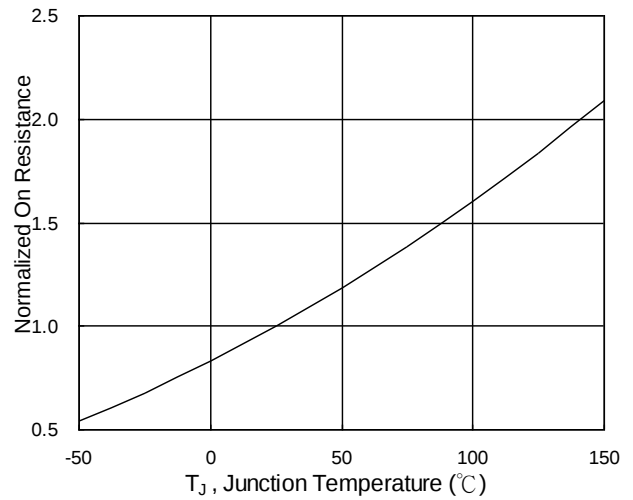


Fig.6 Normalized $R_{DS(on)}$ v.s T_J

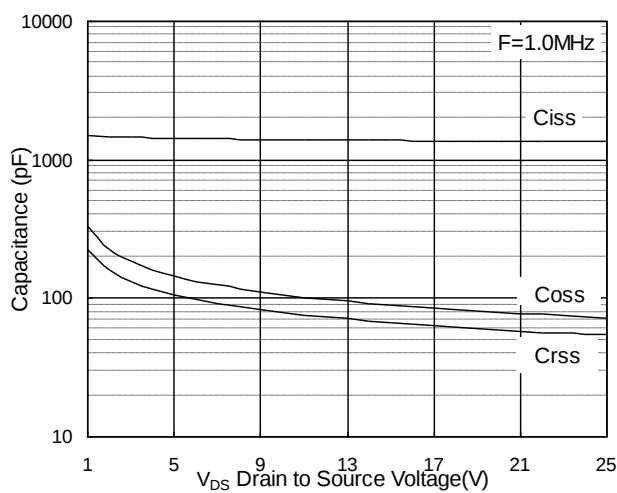


Fig.7 Capacitance

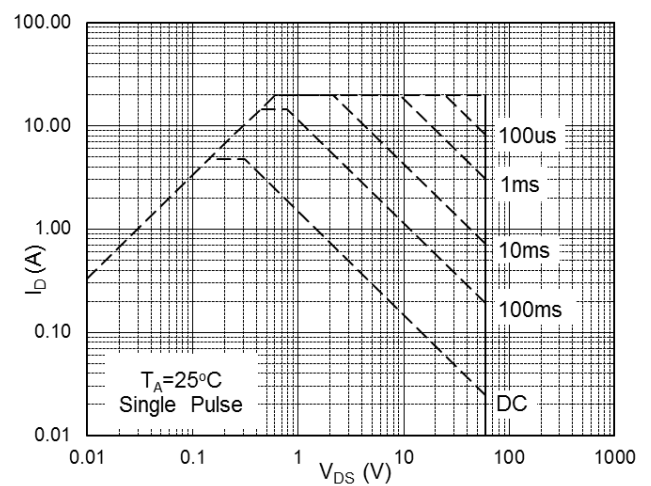


Fig.8 Safe Operating Area

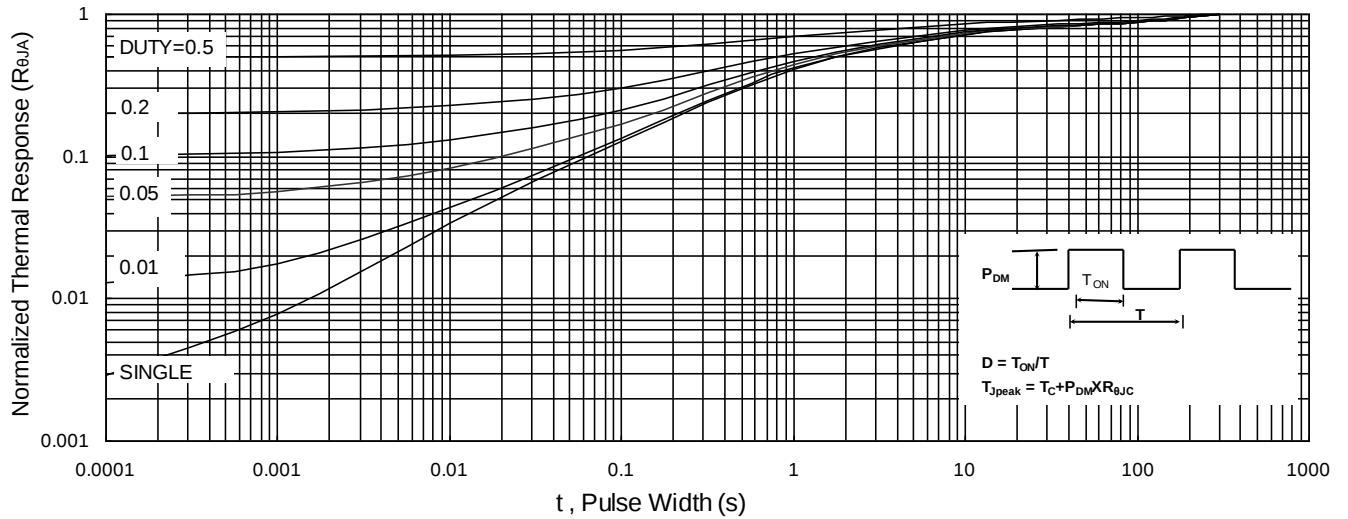


Fig.9 Normalized Maximum Transient Thermal Impedance

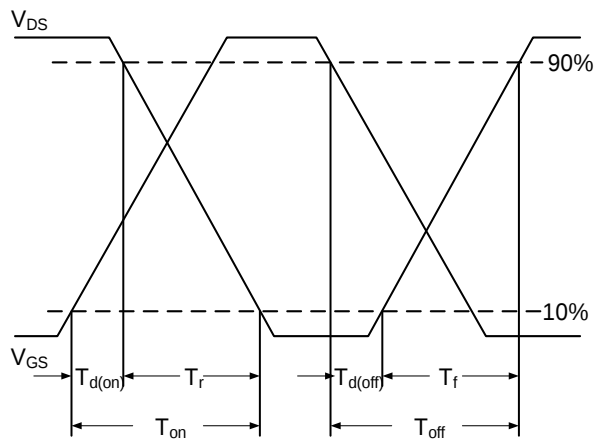


Fig.10 Switching Time Waveform

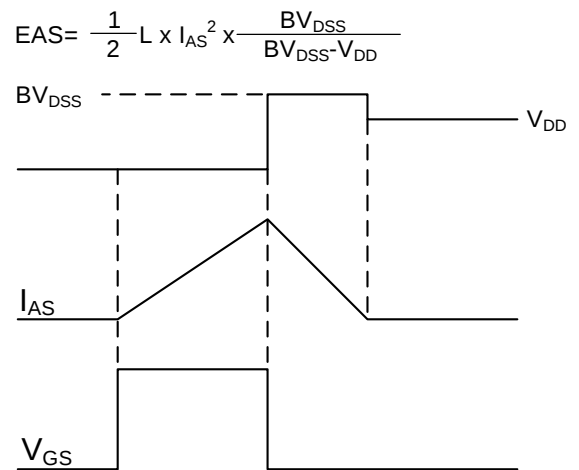


Fig.11 Unclamped Inductive Waveform